

Notice of References Cited

Application/Control No.

09/870,955

Applicant(s)/Patent Under
Reexamination
HILLIGES, KLAUS-DIETER

Examiner

Joseph D. Torres

Art Unit

2133

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Cheung et al., "Tester for multiple integrated circuit - produces sequence of test signals and has programmable memory for storing independent sequence", Copyright 1999 Derwent Information Ltd, Derwent-Week: 200246
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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